

Dual P-Channel Enhancement Mode Power MOSFET

DESCRIPTION

The HM4953 uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a load switch or in PWM applications.

GENERAL FEATURES

• $V_{DS} = -30V, I_{D} = -5.1A$

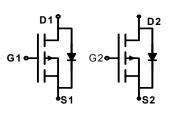
 $R_{DS(ON)}$ < 105m Ω @ V_{GS} =-4.5V

 $R_{DS(ON)}$ < 55m Ω @ V_{GS} =-10V

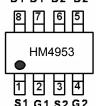
- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package

Application

- PWM applications
- Load switch
- Power management



Schematic diagram
D1 D1 D2 D2



Marking and pin Assignment



SOP-8 top view

Package Marking And Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
HM4953	HM4953	SOP-8	Ø330mm	12mm	2500 units

Absolute Maximum Ratings (TA=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	-30	V
Gate-Source Voltage	V _{GS}	±20	V
Drain Current-Continuous	I _D	-5.1	Α
Drain Current-Pulsed (Note 1)	I _{DM}	-20	Α
Maximum Power Dissipation	P _D	2.5	W
Operating Junction and Storage Temperature Range	T _J ,T _{STG}	-55 To 150	$^{\circ}$ C

Thermal Characteristic

Thermal Resistance, Junction-to-Ambient (Note 2)	R _{0JA}	50	°C/W
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Electrical Characteristics (TA=25℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =-250μA	-30	-33	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V_{DS} =-24V, V_{GS} =0V	-	-	-1	μΑ

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Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA		
On Characteristics (Note 3)								
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=-250\mu A$	-1	-1.6	-3	V		
Drain-Source On-State Resistance	В	V _{GS} =-10V, I _D =-5.1A	-	48	55	mΩ		
Diditi-Source Off-State Resistance	R _{DS(ON)}	V _{GS} =-4.5V, I _D =-4.2A	-	73	105	mΩ		
Forward Transconductance	g FS	V _{DS} =-15V,I _D =-4.5A		7	-	S		
Dynamic Characteristics (Note4)								
Input Capacitance	C_{lss}	\/ - 45\/\/ -0\/	-	1040	-	PF		
Output Capacitance	C _{oss}	V_{DS} =-15V, V_{GS} =0V, F=1.0MHz	-	420	-	PF		
Reverse Transfer Capacitance	C _{rss}	F = 1.0WI112	-	150	-	PF		
Switching Characteristics (Note 4)								
Turn-on Delay Time	$t_{d(on)}$		-	15	-	nS		
Turn-on Rise Time	t _r	V _{DD} =-15V, ID=-1A,	-	13	-	nS		
Turn-Off Delay Time	t _{d(off)}	V_{GS} =-10 V , R_{GEN} =6 Ω	-	58	-	nS		
Turn-Off Fall Time	t _f		-	21	-	nS		
Total Gate Charge	Qg		-	12	-	nC		
Gate-Source Charge	Q _{gs}	V _{DS} =-15V,I _D =-5.1A,V _{GS} =-10V	-	2.2	-	nC		
Gate-Drain Charge	Q _{gd}		-	3	-	nC		
Drain-Source Diode Characteristics	•			•				
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =-1.7A	-	-	-1.2	V		

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

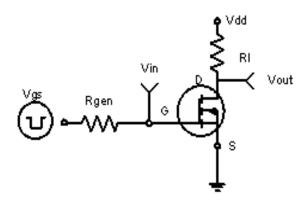


Figure 1:Switching Test Circuit

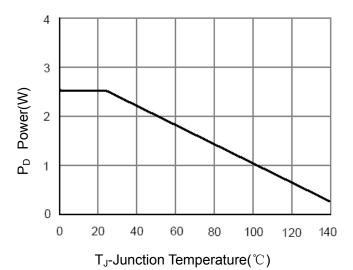


Figure 3 Power Dissipation

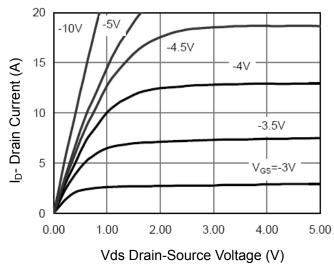


Figure 5 Output CHARACTERISTICS

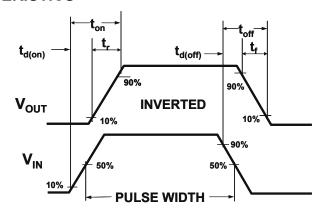


Figure 2:Switching Waveforms

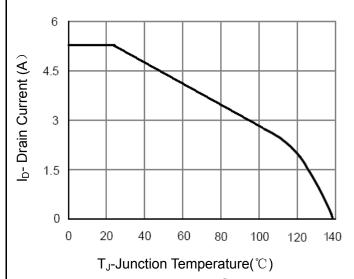


Figure 4 Drain Current

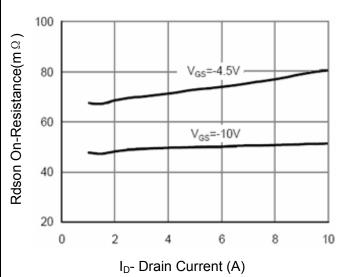


Figure 6 Drain-Source On-Resistance

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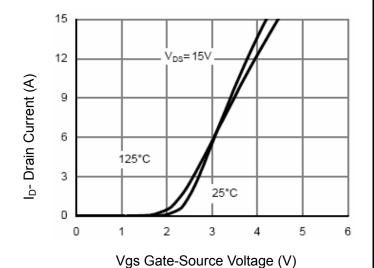
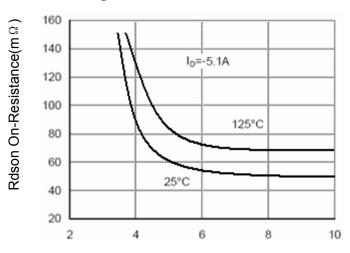


Figure 7 Transfer Characteristics



Vgs Gate-Source Voltage (V)

Figure 9 Rdson vs Vgs

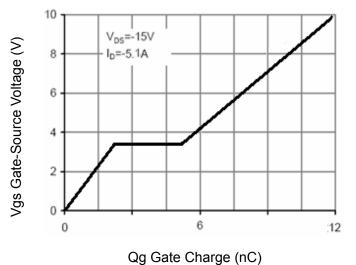
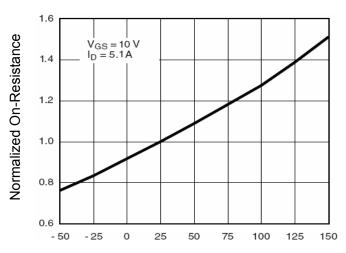
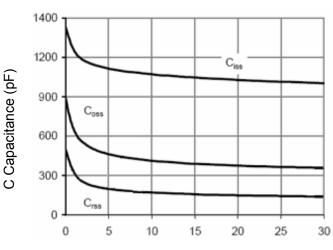


Figure 11 Gate Charge



 T_J -Junction Temperature($^{\circ}$ C)

Figure 8 Drain-Source On-Resistance



Vds Drain-Source Voltage (V)

Figure 10 Capacitance vs Vds

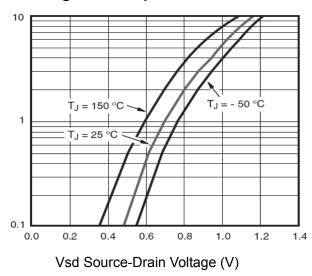


Figure 12 Source- Drain Diode Forward

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Is- Reverse Drain Current (A)

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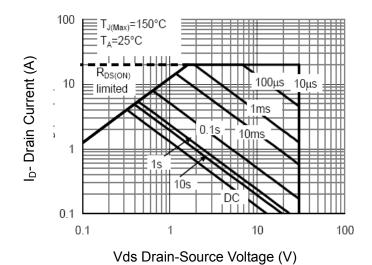


Figure 13 Safe Operation Area

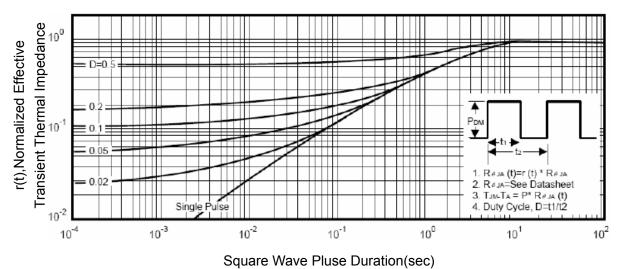
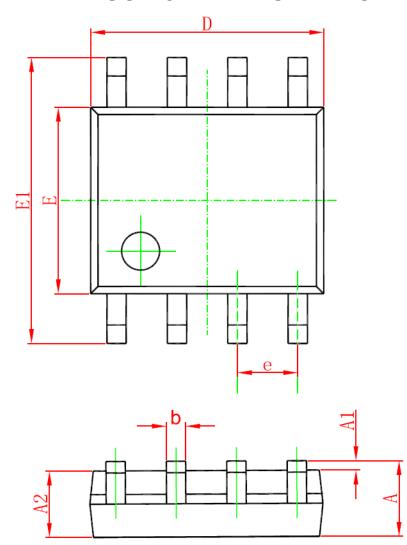
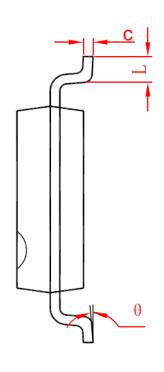


Figure 14 Normalized Maximum Transient Thermal Impedance

SOP-8 PACKAGE IN FORMATION





Comb a l	Dimensions I	n Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
А	1. 350	1. 750	0. 053	0. 069	
A1	0. 100	0. 250	0. 004	0. 010	
A2	1. 350	1. 550	0. 053	0. 061	
b	0. 330	0. 510	0. 013	0. 020	
С	0. 170	0. 250	0.006	0. 010	
D	4. 700	5. 100	0. 185	0. 200	
E	3. 800	4. 000	0. 150	0. 157	
E1	5. 800	6. 200	0. 228	0. 244	
е	1. 270	(BSC)	0.050	(BSC)	
L	0. 400	1. 270	0. 016	0. 050	
θ	0°	8°	0°	8°	

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